

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTORNEY DOCKET NO.

1186.1032

APPLICATION NO.

~~Unassigned~~

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

FIRST NAMED INVENTOR

Masao MOGI et al.

10/762 286

FILING DATE

January 23, 2004

GROUP ART UNIT

~~Unassigned~~

2854

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
ne	AA	4,947,746	08/14/90	Jeschke et al.	101	211	-
ne	AB	5,031,534	07/16/91	Brunner	101	365	
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATIO N YES NO	
ne	AG	4-18847	04/27/92	Japan	-	-		X
ne	AH	28-31107	09/25/98	Japan	-	-		X
ne	AI	61-40159	02/26/86	Japan	-	-		X
ne	AJ	2000-127348	05/09/00	Japan	-	-		X
ne	AK	2001-80052	03/27/01	Japan	-	-		X
	AL							
	AM							

OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

	AN	
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EXAMINER

MINDA CHAU

DATE CONSIDERED

01-21-05

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Sheet 1 of 1

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTORNEY DOCKET NO. 1186.1032	APPLICATION NO. 10/762,286
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)		FIRST NAMED INVENTOR Masao MOGI et al.	
		FILING DATE January 23, 2004	GROUP ART UNIT 2853

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
ne	AA	4,852,485	08/01/89	Brunner	101	211	-
	AB						
	AC						
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO	
	AG							
	AH							
	AI							
	AJ							
	AK							
	AL							

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

				TRANSLATION YES NO	
ne	AM	Masao Mogi, et al., "The Relationship between the Dot Area Monitored and Printing Quality in Offset Lithography", TAGA (Technical Association of the Graphic Arts), 2000 Proceedings		In English	

EXAMINER NINH CHAU	DATE CONSIDERED 01-21-05
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.